## Search Notes



## Application/Control No. Applicant(s)/Patent under Reexamination

10/790,879 Examiner Ted M. Wang Reexamination
MOCHIZUKI, HIDEAKI

Art Unit

2611

SEARCHED					
Class	Subclass	Date	Examiner		
375	239, 357	5/21/2008	TW		
370	216, 506	5/21/2008	TW		
370	512	5/21/2008	TW		
340	512	5/21/2008	TW		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	239, 357	5/21/2008	TW	
340	512	5/21/2008	TW	
370	216, 506	5/21/2008	TW	
370/512		5/21/2008	TW	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	5/21/2008	TW			
ODP- Searched and reviewed from EAST and PALM	5/21/2008	TW			
Inventor search- Mochizuki with Hideaki	5/21/2008	TW			
IEEExplor - Adavnce - fram* pulse and mask* and (alarm or fault or fail*)	5/21/2008	TW			
IEEExplor - Author -Mochizuki Hideaki	5/21/2008	TW			